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MIMO: Multiple Input Multiple Output Technology for Physical-Layer Security

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Deadline for manuscript submissions:

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Message from the Guest Editors

The multiple input multiple output (MIMO) scheme is one of the most important technologies in modern wireless communication systems, including wireless LAN and 4G to beyond 5G systems. Most of the physical-layer technologies for MIMO systems have been focused on enhancing the error performance and spectral efficiency of the system, rather than on securing privacy. Dramatically increasing traffic demands, especially on machine-type communications, requires more secure communications for privacy protection.

This Special Issue aims to collect new developments and methodologies, best practices and applications of MIMO technologies for PLS. We welcome submissions which provide the community with the most recent advancements on all aspects of MIMO transmission technologies for PLS, as detailed in the list of keywords below, though other relevant submissions are also welcome.











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Message from the Editor-in-Chief

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